

## UNISONIC TECHNOLOGIES CO., LTD

UT10P06 Power MOSFET

# -10A, -60V P-CHANNEL POWER MOSFET

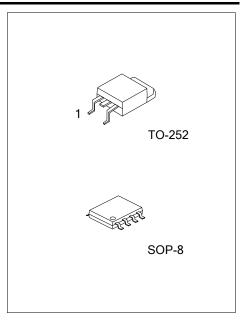
#### DESCRIPTION

The UTC **UT10P06** is a P-channel MOSFET, it uses UTC's advanced technology to provide the customers with a minimum on state resistance and low gate charge, etc.

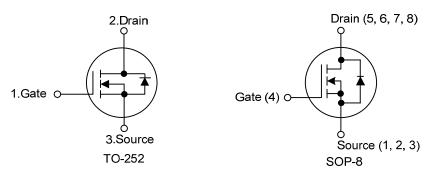
The UTC **UT10P06** is suitable for load switch and battery protection applications.

#### **■ FEATURES**

- \*  $R_{DS(ON)} \le 130 \text{ m}\Omega$  @  $V_{GS}$ =-10V,  $I_{D}$ =-2.5A  $R_{DS(ON)} \le 160 \text{ m}\Omega$  @  $V_{GS}$ =-4.5V,  $I_{D}$ =-2.5A
- \* Improved dv/dt capability
- \* Fast switching



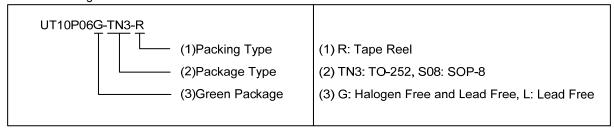
#### ■ SYMBOL



#### ■ ORDERING INFORMATION

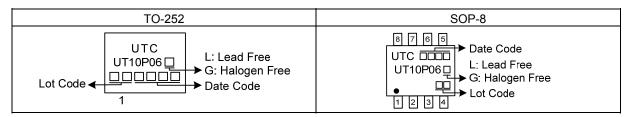
Ordering Number		Daalaasa	Pin Assignment						Daaldaa			
Lead Free	Halogen Free	Package	1	2	3	4	5	6	7	8	Packing	
UT10P06L-TN3-R	UT10P06G-TN3-R	TO-252	G	D	S	-	-	-	-	-	Tape Reel	
UT10P06L-S08-R	UT10P06G-S08-R	SOP-8	S	S	S	G	D	D	D	D	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



UT10P06

## ■ MARKING



### ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		$V_{DSS}$	-60	V
Gate-Source Voltage		$V_{GSS}$	±20	V
Continuous Drain Current		I <sub>D</sub>	-10	Α
Pulsed Drain Current (Note 2)		I <sub>DM</sub>	-20	Α
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	5	mJ
Power Dissipation	TO-252	P <sub>D</sub>	30	W
	SOP-8		1.2	W
Junction Temperature	unction Temperature		+150	°C
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = -0.1mH,  $I_{AS}$  = -10A,  $V_{DD}$  = -50V,  $R_{G}$  = -25 $\Omega$ , Starting  $T_{J}$  = 25 $^{\circ}$ C

#### ■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT	
Junction to Ambient	TO-252	0	50	°C/W	
	SOP-8	$\theta_{JA}$	125	°C/W	
Junction to Case	TO-252	0	4.16	°C/W	
	SOP-8	AlC	θ <sub>JC</sub>	A¹C	104

Note: Device mounted on FR-4 substrate  $P_{\text{C}}$  board, 2oz copper, with 1inch square copper plate.

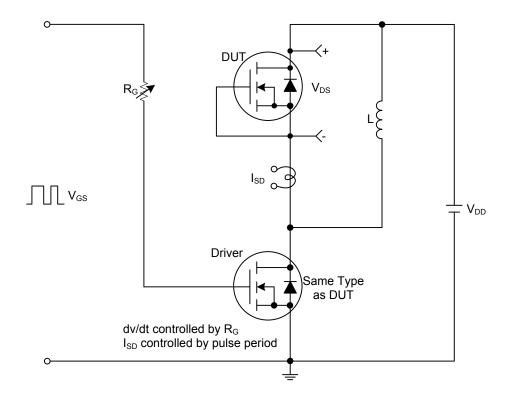
## ■ **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub>=25°C, unless otherwise specified)

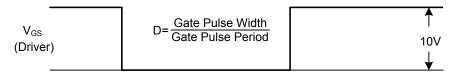
PARAMETER	SYMBOL	BOL TEST CONDITIONS		TYP	MAX	UNIT				
STATIC PARAMETERS										
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V	-60			V				
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-60V, V <sub>GS</sub> =0V			-1	μA				
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS}$ =±20V, $V_{DS}$ =0V			±100	nΑ				
ON CHARACTERISTICS										
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}$ , $I_{D}=-250\mu A$	-1.0		-3.0	V				
Static Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	$V_{GS}$ =-10V, $I_{D}$ =-2.5A			130	mΩ				
Static Drain-Source On-State Resistance		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-2.5A			160	mΩ				
DYNAMIC PARAMETERS										
Input Capacitance	$C_{ISS}$			677.9		pF				
Output Capacitance	Coss	$V_{GS}$ =0V, $V_{DS}$ =-10V, f=1.0MHz		57.1		pF				
Reverse Transfer Capacitance	$C_{RSS}$			47.9		pF				
SWITCHING PARAMETERS										
Total Gate Charge	$Q_G$	\\ - 25\\ \\ -0\\   - 10A		20		nC				
Gate to Source Charge	$Q_GS$	$V_{DS}$ =-25V, $V_{GS}$ =0V, $I_{D}$ =-10A $R_{G}$ =25Ω (Note 1, 2)		3.6		nC				
Gate to Drain Charge	$Q_GD$	R <sub>G</sub> -23Ω (Note 1, 2)		4.2		nC				
Turn-ON Delay Time	$t_{D(ON)}$			4		ns				
Turn-ON Rise Time	$t_R$	$V_{DS}$ =-30V, $V_{GS}$ =-10V, $I_{D}$ =-10A,		16.26		ns				
Turn-OFF Delay Time	$t_{D(OFF)}$	R <sub>G</sub> =3Ω (Note 1, 2)		25.2		ns				
Turn-OFF Fall-Time	t <sub>F</sub>			18.11		ns				
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS										
Maximum Body-Diode Continuous	la				-10	Α				
Current	Is				-10	Α				
Diode Forward Voltage	$V_{SD}$	I <sub>S</sub> =-10A,V <sub>GS</sub> =0V			-1.4	V				

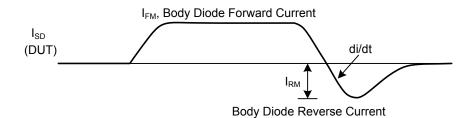
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

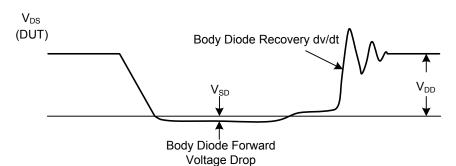
2. Essentially independent of operating temperature.

## ■ TEST CIRCUITS AND WAVEFORMS



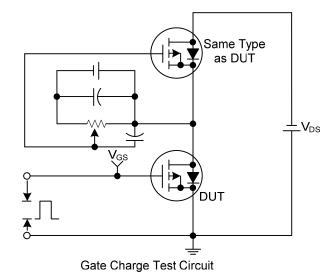


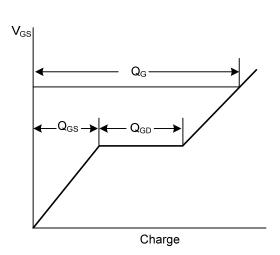




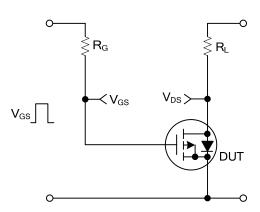
Peak Diode Recovery dv/dt Test Circuit and Waveforms

## ■ TEST CIRCUITS AND WAVEFORMS

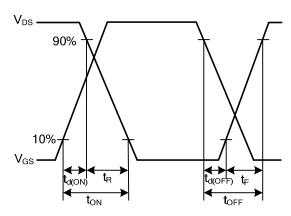




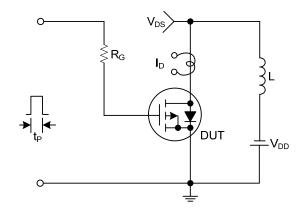
Gate Charge Waveforms



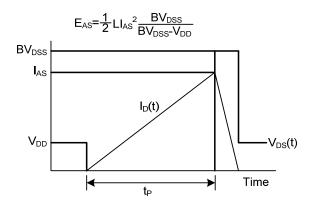
Resistive Switching Test Circuit



Resistive Switching Waveforms



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

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